

<b>Notice of References Cited</b>	Application/Control No. 10/541,797	Applicant(s)/Patent Under Reexamination YAHAGI, MASAHIKO	
	Examiner <i>K. Afshar</i> Kamran Afshar, 571-272-7796	Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0114295	08-2002	Takahiro et al.	370/329
*	B	US-6,594,501	07-2003	Black et al.	455/522
*	C	US-2003/0114167	06-2003	Chen et al.	455/453
*	D	US-6,708,042	03-2004	Hayakawa, Tadashi	455/522
*	E	US-2004/0203336	10-2004	Sinnarajah et al.	455/452.1
*	F	US-5,077,828	12-1991	Waldroup, Anthony B.	455/514
*	G	US-6,847,828	01-2005	Miyoshi et al.	455/522
*	H	US-6,934,556	08-2005	Takano, Michiaki	455/522
*	I	US-7,277,694	10-2007	Sinnarajah et al.	455/561
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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